


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/688,684	YI, SEUNG HYUN	
	Examiner	Art Unit	
	Hai L. Nguyen	2816	

SEARCHED			
Class	Subclass	Date	Examiner
327	141,147, 149,150, 153,155, 156	4/18/2005	HLN
↓	158,159		
↓	161-163		
331	1A,1R		
↓	DIG.2		
↓	18,25		
375	373,375	4/19/2005	
✓	376	✓	✓

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Shepardize Search	4/19/2005	HLN